

1. Record Nr.	UNINA9910703779403321
Autore	Roth Don J.
Titolo	The effect of experimental variables on industrial X-ray micro-computed sensitivity / / Donald J. Roth, Richard W. Rauser
Pubbl/distr/stampa	Cleveland, Ohio : , : National Aeronautics and Space Administration, Glenn Research Center, , December 2014
Descrizione fisica	1 online resource (37 pages) : color illustrations
Collana	NASA/TM ; ; 2014-218332
Soggetti	Radiography Computer aided tomography X ray analysis Signal to noise ratios Modulation transfer function
Lingua di pubblicazione	Inglese
Formato	Materiale a stampa
Livello bibliografico	Monografia
Note generali	Title from title screen (viewed on May 15, 2015). "December 2014."
Nota di bibliografia	Includes bibliographical references (page 37).